

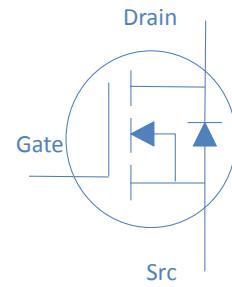
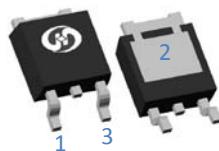
**40V N-Ch Power MOSFET**
**Feature**

- ◇ High Speed Power Switching, Logic Level
- ◇ Enhanced Avalanche Ruggedness
- ◇ 100% UIS Tested, 100% Rg Tested
- ◇ Lead Free, Halogen Free

$V_{DS}$	40	V
$R_{DS(on),typ}$   $V_{GS}=10V$	6	$m\Omega$
$I_D$ (Silicon Limited)	55	A

**Application**

- ◇ Hard Switching and High Speed Circuit
- ◇ DC/DC in Telecoms and Industrial

**TO-252**


Part Number	Package	Marking
HTD070N04	TO-252	TD070N04

**Absolute Maximum Ratings at  $T_j=25^\circ C$  (unless otherwise specified)**

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current (Silicon Limited)	$I_D$	$T_C=25^\circ C$	55	A
		$T_C=100^\circ C$	40	
Drain to Source Voltage	$V_{DS}$	-	40	V
Gate to Source Voltage	$V_{GS}$	-	$\pm 20$	V
Pulsed Drain Current	$I_{DM}$	-	150	A
Avalanche Energy, Single Pulse	$E_{AS}$	$L=0.1mH, T_C=25^\circ C$	45	mJ
Power Dissipation	$P_D$	$T_C=25^\circ C$	50	W
Operating and Storage Temperature	$T_J, T_{stg}$	-	-55 to 175	°C

**Absolute Maximum Ratings**

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Ambient	$R_{\theta JA}$	75	°C/W
Thermal Resistance Junction-Case	$R_{\theta JC}$	3	°C/W

**Electrical Characteristics at  $T_j=25^\circ\text{C}$  (unless otherwise specified)**
**Static Characteristics**

Parameter	Symbol	Conditions	Value			Unit
			min	typ	max	
Drain to Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_D=250\mu\text{A}$	40	-	-	V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}, I_D=250\mu\text{A}$	1.5	1.9	3.2	
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=32\text{V}, T_j=25^\circ\text{C}$	-	-	1	$\mu\text{A}$
		$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=30\text{V}, T_j=125^\circ\text{C}$	-	-	25	
Gate to Source Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	nA
Drain to Source on Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=10\text{V}, I_D=24\text{A}$	-	6	7	$\text{m}\Omega$
		$V_{\text{GS}}=5\text{V}, I_D=16\text{A}$	-	8	11	
Transconductance	$g_{\text{fs}}$	$V_{\text{DS}}=5\text{V}, I_D=24\text{A}$	-	28	-	S
Gate Resistance	$R_G$	$V_{\text{GS}}=15\text{mV}, V_{\text{DS}}=0\text{V}, f=1\text{MHz}$	-	2.0	-	$\Omega$

**Dynamic Characteristics**

Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=20\text{V}, f=1\text{MHz}$	-	1915	-	pF
Output Capacitance	$C_{\text{oss}}$		-	260	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	208	-	
Total Gate Charge	$Q_g(10\text{V})$	$V_{\text{DD}}=20\text{V}, I_D=24\text{A}, V_{\text{GS}}=10\text{V}$	-	50	-	nC
Gate to Source Charge	$Q_{\text{gs}}$		-	6	-	
Gate to Drain (Miller) Charge	$Q_{\text{gd}}$		-	13	-	
Turn on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=20\text{V}, I_D=1\text{A}, V_{\text{GS}}=10\text{V}, R_G=6\Omega,$	-	9	-	ns
Rise time	$t_r$		-	20	-	
Turn off Delay Time	$t_{\text{d}(\text{off})}$		-	30	-	
Fall Time	$t_f$		-	12	-	

**Reverse Diode Characteristics**

Diode Forward Voltage	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_F=55\text{A}$	-		1.3	V
Reverse Recovery Time	$t_{\text{rr}}$	$I_F=25\text{A}, dI_F/dt=100\text{A}/\mu\text{s}$	-	75	-	ns
Reverse Recovery Charge	$Q_{\text{rr}}$		-	50	-	nC

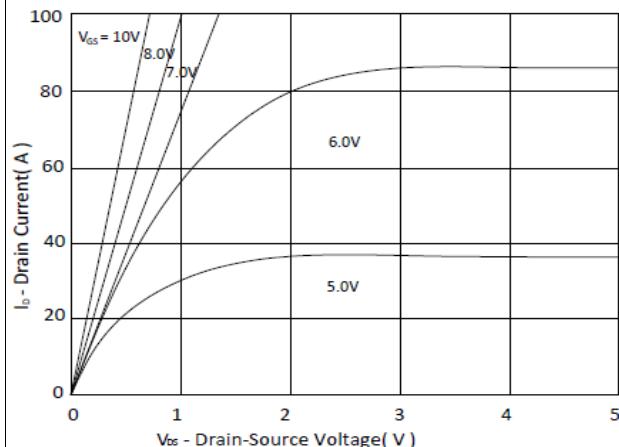
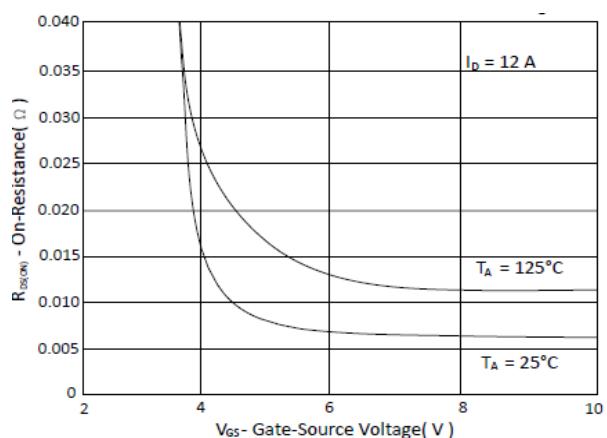
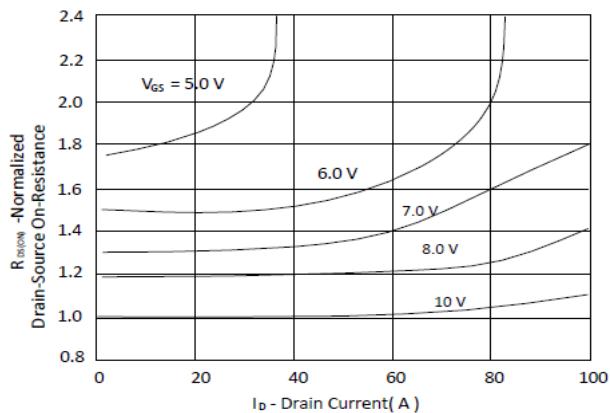
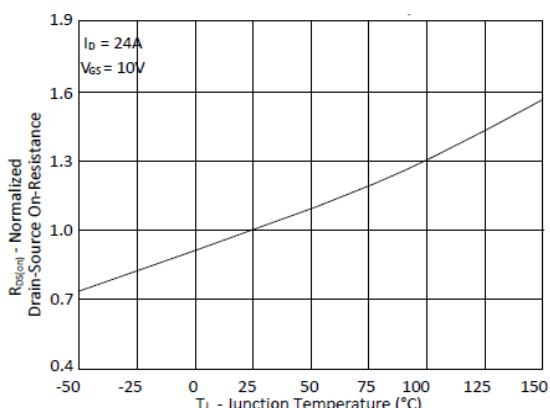
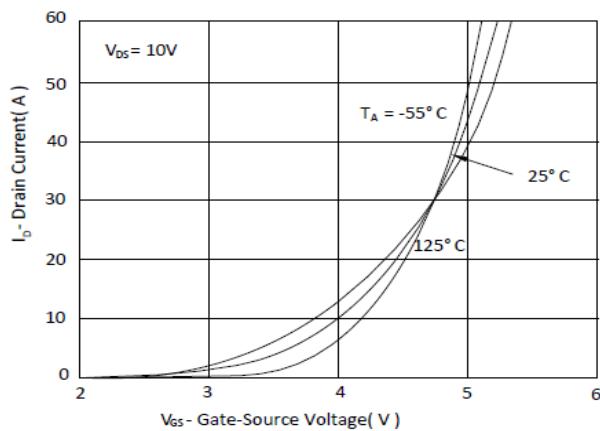
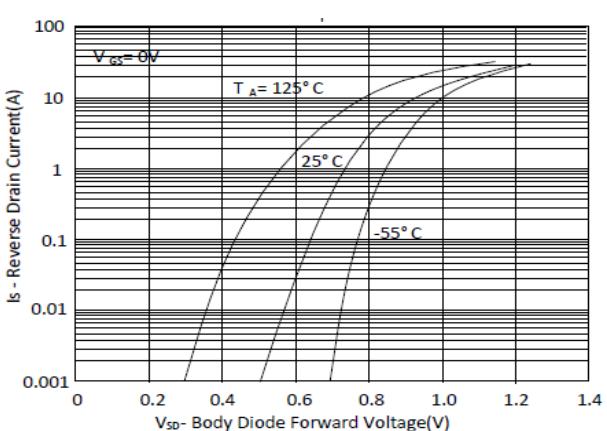
**Fig 1. Typical Output Characteristics**

**Figure 2. On-Resistance vs. Gate-Source Voltage**

**Figure 3. On-Resistance vs. Drain Current and Gate Voltage**

**Figure 4. Normalized On-Resistance vs. Junction Temperature**

**Figure 5. Typical Transfer Characteristics**

**Figure 6. Typical Source-Drain Diode Forward Voltage**


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

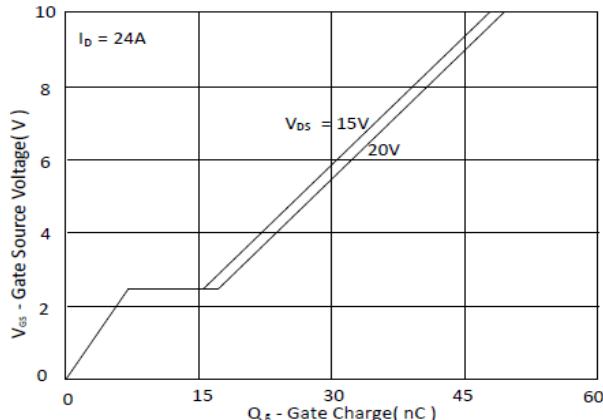


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

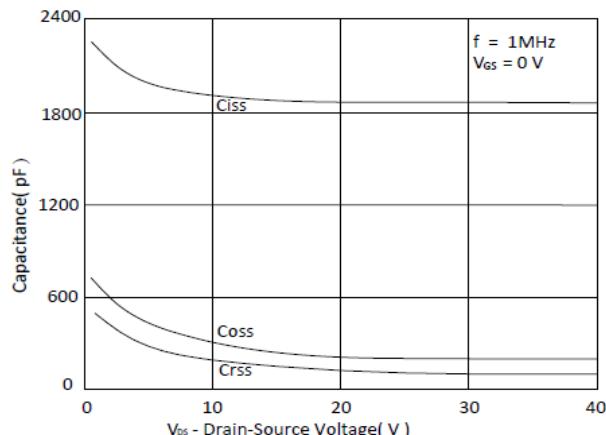


Figure 9. Maximum Safe Operating Area

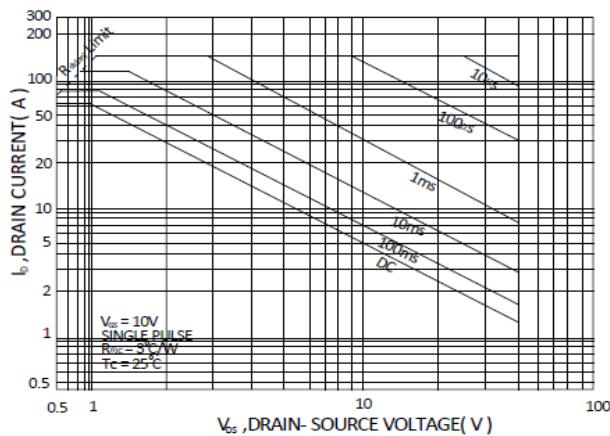


Figure 10. Single Pulse Maximum Power Dissipation

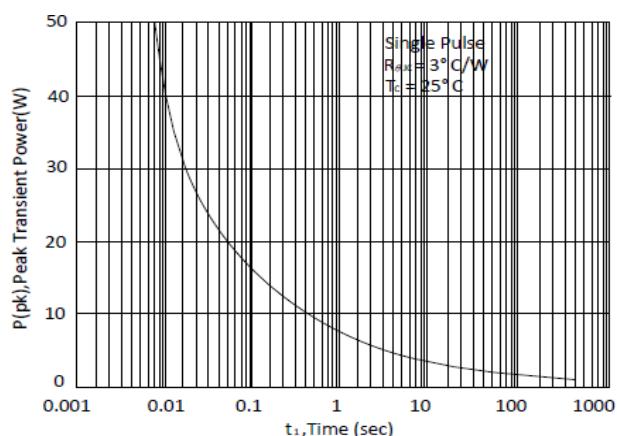
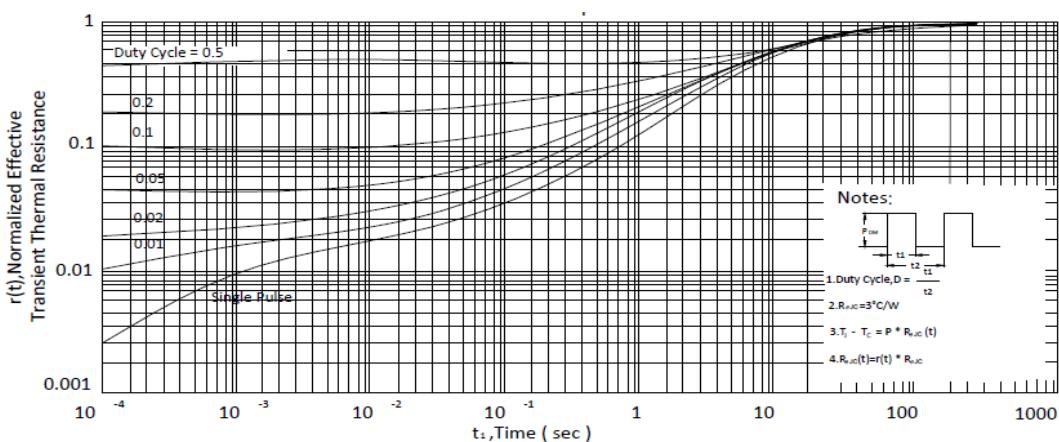
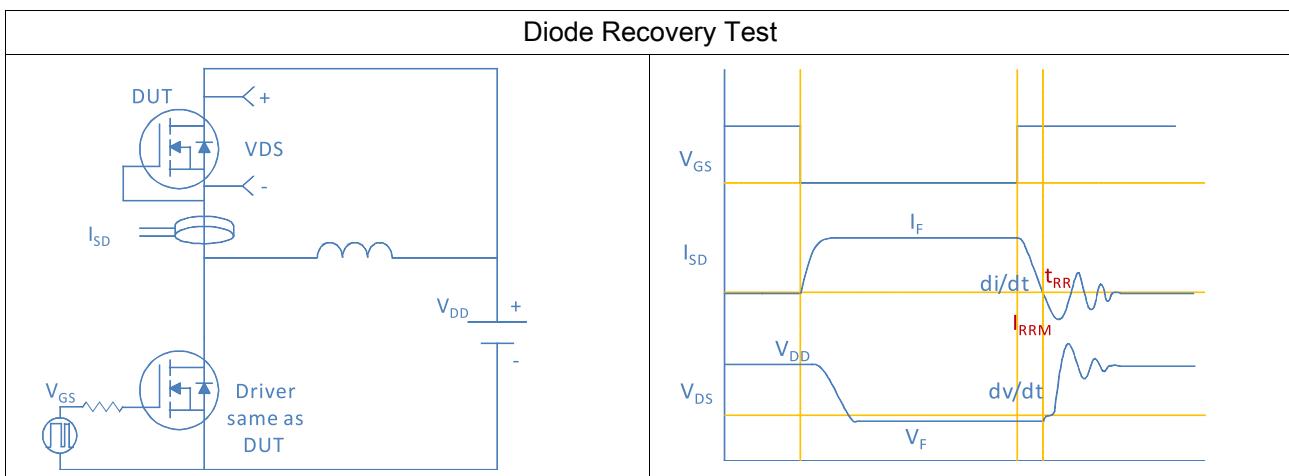
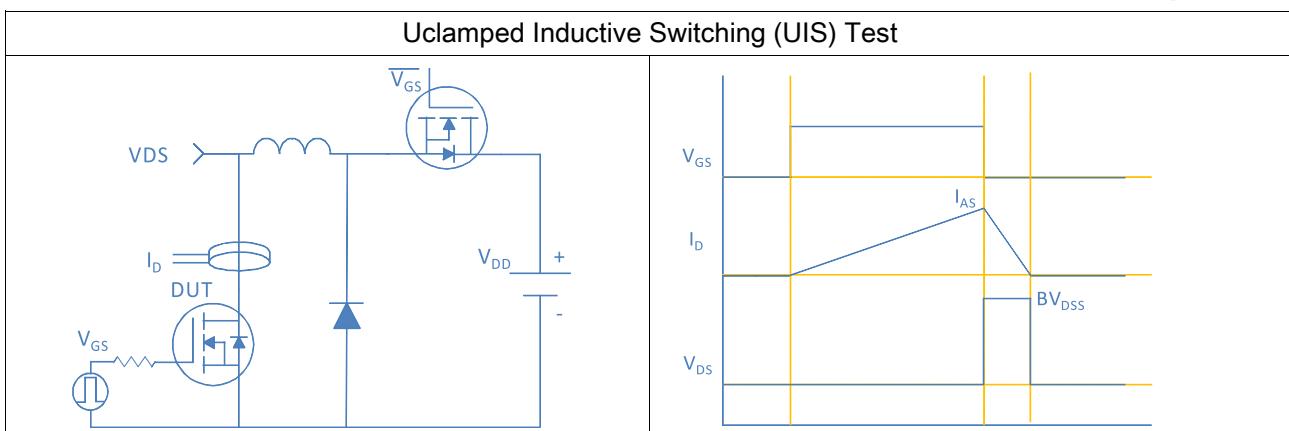
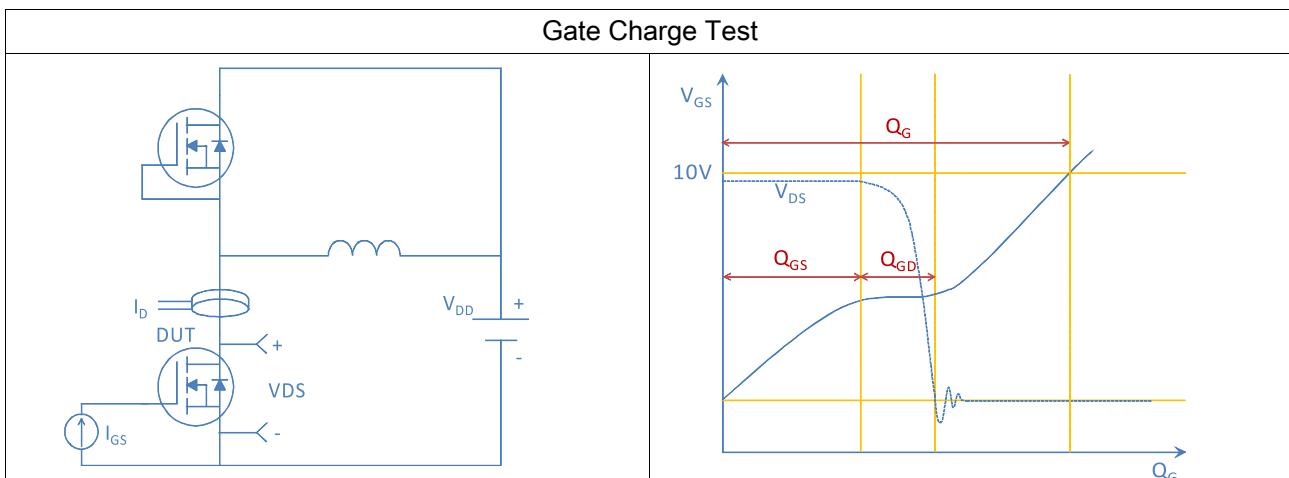
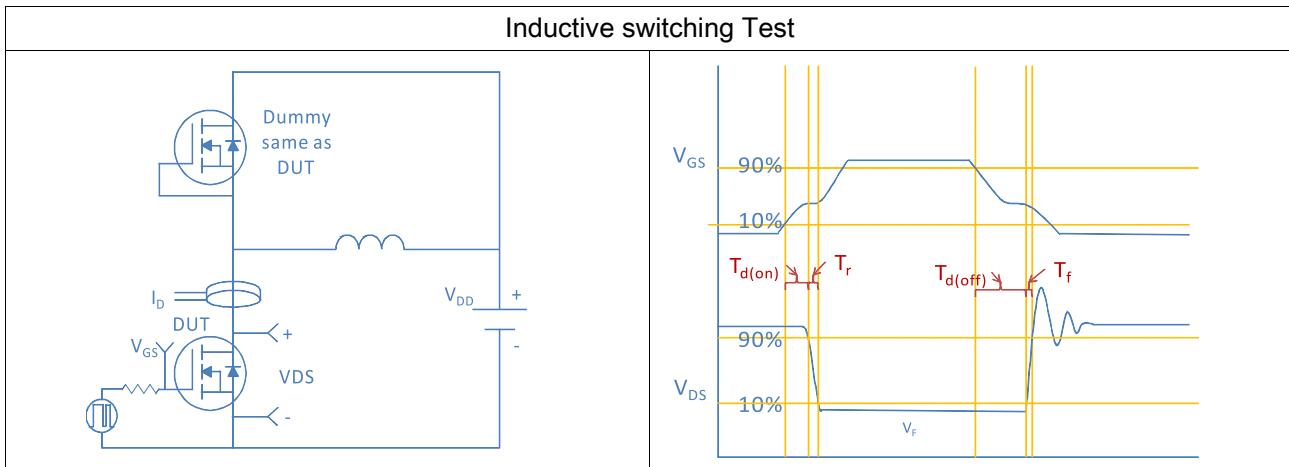
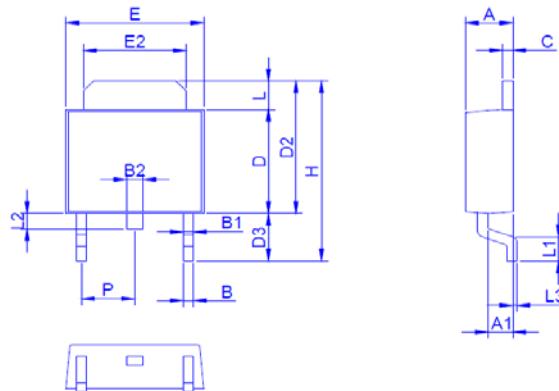


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient





**Package Outline**
**TO-252, 3leads**


Dimension	A	A1	B	B1	B2	C	D	D2	D3	E	E2	H	L	L1	L2	L3	P
Min.	2.10	0.95	0.30	0.40	0.60	0.40	5.30	6.70	2.20	6.40	4.80	9.20	0.89	0.90	0.50	0.00	2.10
Max.	2.50	1.30	0.85	0.94	1.00	0.60	6.20	7.30	3.00	6.70	5.45	10.15	1.70	1.65	1.10	0.30	2.50